HIGH POWER SWITCHING USE INSULATED TYPE

CM500HA-34A

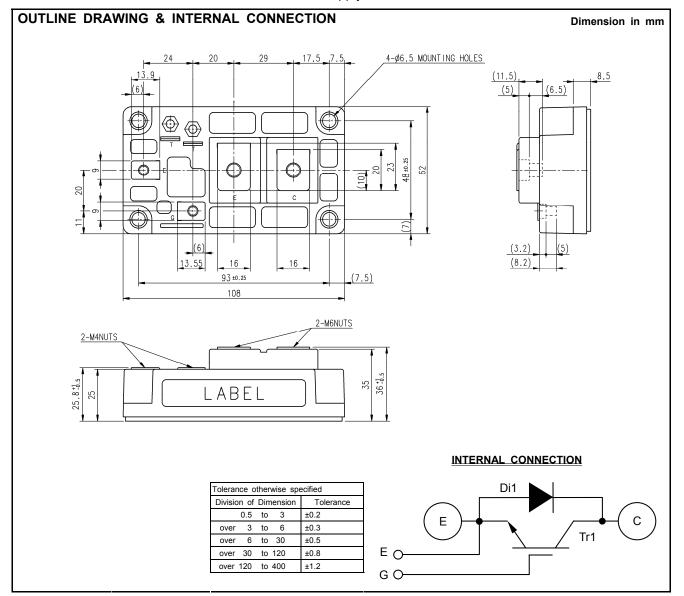


- Flat base Type
 Copper (non-plating) base plate
 No accessory (terminal screw) attach
- •RoHS Directive compliant

Single

APPLICATION

AC Motor Control, Motion/Servo Control, Power supply, etc.



HIGH POWER SWITCHING USE INSULATED TYPE

ABSOLUTE MAXIMUM RATINGS (T_j=25 °C, unless otherwise specified)

Symbol	Item	Conditions	Rating	Unit	
V _{CES}	Collector-emitter voltage	G-E short-circuited	1700	V	
V_{GES}	Gate-emitter voltage	C-E short-circuited	±20	V	
Ic	Collector current	DC, T _C =87 °C (Note.2)	500	Α	
I _{CRM}	Collector current	Pulse, Repetitive (Note.3)	1000		
P _{tot}	Total power dissipation	T _C =25 °C (Note.2, 4)	5000	W	
I _E (Note.1)	Emitter current	T _C =25 °C (Note.2, 4)	500	Α	
I _{ERM} (Note.1)	(Free wheeling diode forward current)	Pulse, Repetitive (Note.3)	1000	A	
Tj	Junction temperature	-	-40 ~ +150	°C	
T _{stg}	Storage temperature -		-40 ~ +125]	
V _{isol}	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	3500	V	

MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions		Limits			Unit
				Min.	Тур.	Max.	Offic
M_t		Main terminals	M 6 screw	1.96	2.45	2.94	
M_t	Mounting torque	Auxiliary terminals	M 4 screw	0.98	1.18	1.47	N⋅m
Ms		Mounting to heat sink	M 6 screw	1.96	2.45	2.94	
m	Weight	-		-	480	-	g
ec	Flatness of base plate	On the centerline X, Y	(Note.5)	±0	-	+100	μm

ELECTRICAL CHARACTERISTICS (T_j=25 °C, unless otherwise specified)

Symbol	Item	Conditions			Limits		Unit
Symbol	item	Conditions		Min.	Тур.	Max.	Ullit
I _{CES}	Collector-emitter cut-off current	V _{CE} =V _{CES} , G-E short-circuited		-	-	1	mA
I _{GES}	Gate-emitter leakage current	±V _{GE} =V _{GES} , C-E short-circuited		-	-	3	μΑ
$V_{\text{GE(th)}}$	Gate-emitter threshold voltage	I _C =50 mA, V _{CE} =10 V		5.5	7	8.5	V
V _{CEsat}	Collector-emitter saturation voltage	I _C =500 A (Note.6),	T _j =25 °C	-	2.2	3.0	V
V CEsat		V _{GE} =15 V	T _j =125 °C	-	2.45	-	v
Cies	Input capacitance			-	-	120	
Coes	Output capacitance	V _{CE} =10 V, G-E short-circuited		-	-	14	nF
Cres	Reverse transfer capacitance			-	-	2.6	
Q_G	Gate charge	V _{CC} =1000 V, I _C =500 A, V _{GE} =15 V		-	3300	-	nC
t _{d(on)}	Turn-on delay time	V _{CC} =1000 V, I _C =500 A, V _{GE} =±15 V,		-	-	900	ns ns
tr	Rise time			-	-	500	
t _{d(off)}	Turn-off delay time	R _G =3.0 Ω, Inductive load		-	-	700	
t _f	Fall time			-	-	350	
V _{EC} (Note.1)	Emitter-collector voltage	I _E =500 A (Note.6), G-E short-circuited		-	2.3	3.2	V
t _{rr} (Note.1)	Reverse recovery time	V _{CC} =1000 V, I _E =500 A, V _{GE} =±15 V,		-	-	650	ns
Q _{rr} (Note.1)	Reverse recovery charge	R _G =3.0 Ω, Inductive load		-	50	-	μC
Eon	Turn-on switching energy per pulse	V _{CC} =1000 V, I _C =I _E =500 A,		-	267.8	-	
E _{off}	Turn-off switching energy per pulse	V_{GE} =±15 V, R _G =3.0 Ω , T _j =125 °C, Inductive load		-	138.5	-	mJ
E _{rr} (Note.1)	Reverse recovery energy per pulse			-	98.1	-	
r _g	Internal gate resistance	T _C =25 °C		-	1.0	-	Ω
R _G	External gate resistance	-		3.0	-	10	Ω

THERMAL RESISTANCE CHARACTERISTICS

Symbol	Item	Conditions	Limits	Limits		Unit
		Conditions	Min.	Тур.	Max.	
$R_{th(j-c)Q}$	Thermal resistance (Note.2)	Junction to case, IGBT part	-	-	25	K/kW
$R_{th(j-c)D}$	Thermarresistance	Junction to case, FWDi part	-	-	42	K/kW
R _{th(c-s)}	Contact thermal resistance (Note.2)	Case to heat sink, Thermal grease applied (Note.7)	-	20	-	K/kW



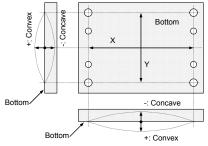
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HIGH POWER SWITCHING USE INSULATED TYPE

- Note.1: Represent ratings and characteristics of the anti-parallel, emitter-collector free wheeling diode (FWDi).
- Note.2: Case temperature (T_c) and heat sink temperature (T_s) are defined on the each surface of base plate and heat sink just under the chips. (Refer to the figure of chip location)

The heat sink thermal resistance $\{R_{th(s-a)}\}$ should measure just under the chips.

- Note.3: Pulse width and repetition rate should be such that the device junction temperature (T_i) dose not exceed T_{imax} rating.
- Note.4: Junction temperature (T_i) should not increase beyond T_{imax} rating.
- Note.5: Base plate flatness measurement point is as in the following figure.



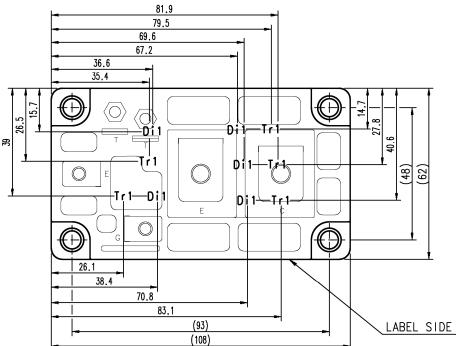
Note.6: Pulse width and repetition rate should be such as to cause negligible temperature rise.

(Refer to the figure of test circuit)

Note.7: Typical value is measured by using thermally conductive grease of λ =0.9 W/(m·K).

CHIP LOCATION (Top view)

Dimension in mm, tolerance: ±1 mm

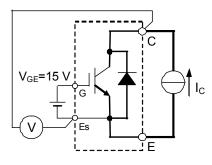


Tr1: IGBT, Di1: FWDi. Each mark points the center position of each chip.

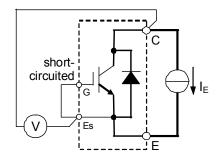


HIGH POWER SWITCHING USE INSULATED TYPE

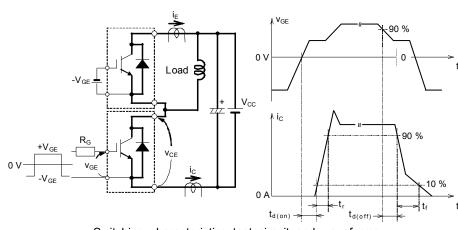
TEST CIRCUIT AND WAVEFORMS



 V_{CEsat} test circuit



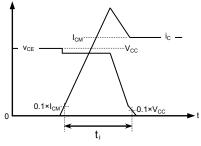
 V_{EC} test circuit



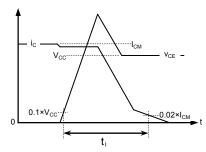
 $\begin{array}{c|c} I_E & Q_{rr} = 0.5 \times I_{rr} \times t_{rr} \\ \hline \\ 0 \text{ A} & I_{rr} & \\ \hline \\ I_{rr} & 0.5 \times I_{rr} \end{array}$

Switching characteristics test circuit and waveforms

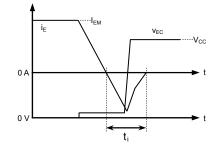
 $t_{rr},\ Q_{rr}$ test waveform



IGBT Turn-on switching energy



IGBT Turn-off switching energy



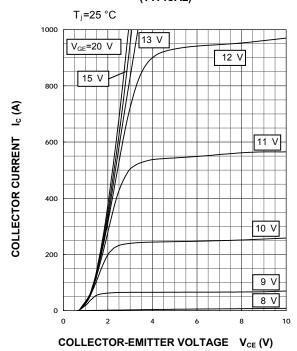
FWDi Reverse recovery energy

Turn-on, Turn-off switching and Reverse recovery energy test waveforms (integral range)

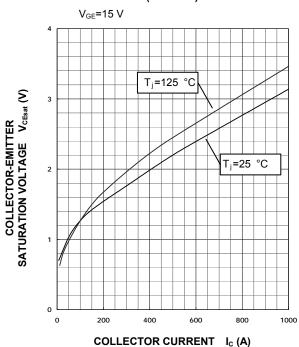
HIGH POWER SWITCHING USE INSULATED TYPE

PERFORMANCE CURVES

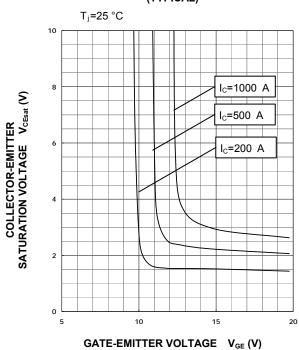
OUTPUT CHARACTERISTICS (TYPICAL)



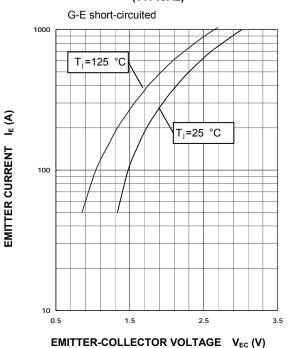
COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)

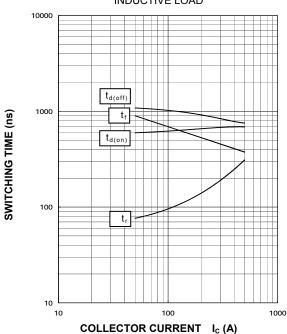




HIGH POWER SWITCHING USE INSULATED TYPE

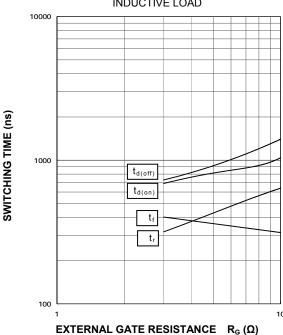
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

 V_{CC} =1000 V, V_{GE} =±15 V, R_G =3.0 Ω , T_j =125 °C INDUCTIVE LOAD



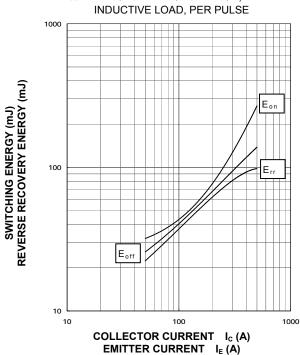
$\begin{array}{c} \textbf{HALF-BRIDGE}\\ \textbf{SWITCHING CHARACTERISTICS}\\ \textbf{(TYPICAL)}\\ \textbf{V}_{\text{CC}}\text{=}1000~\text{V, I}_{\text{C}}\text{=}500~\text{A, V}_{\text{GE}}\text{=}\pm15~\text{V, T}_{\text{j}}\text{=}125~^{\circ}\text{C} \end{array}$

 V_{CC} =1000 V, I_C =500 A, V_{GE} =±15 V, I_j =125 C INDUCTIVE LOAD



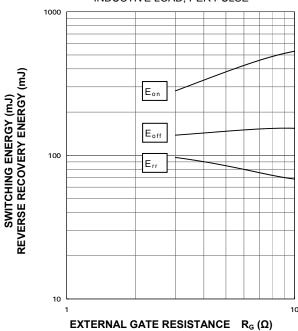
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

 V_{CC} =1000 V, V_{GE} =±15 V, R_G =3.0 Ω , T_j =125 °C



HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

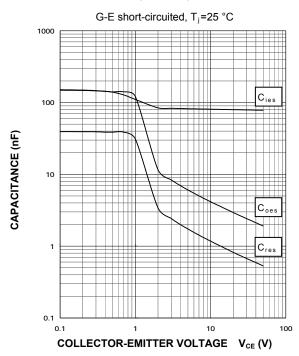
V_{CC}=1000 V, I_C/I_E=500 A, V_{GE}=±15 V, T_j=125 °C INDUCTIVE LOAD, PER PULSE



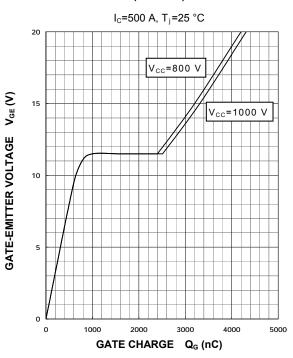


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CAPACITANCE CHARACTERISTICS (TYPICAL)

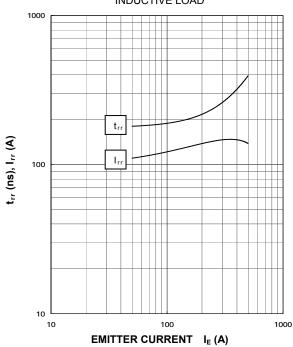


GATE CHARGE CHARACTERISTICS (TYPICAL)



FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)

 V_{CC} =1000 V, V_{GE} =±15 V, R_{G} =3.0 Ω , T_{j} =125 °C INDUCTIVE LOAD



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)

Single pulse, T_C=25°C

ON OND

OND

OND

OND

Reh(j-c)Q=25 K/kW, Reh(j-c)D=42 K/kW

TIME (S)



MITSUBISHI IGBT MODULES CM500HA-34A

HIGH POWER SWITCHING USE INSULATED TYPE

Keep safety first in your circuit designs!

·Mitsubishi Electric Corporation puts the maximum effort into making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them. Trouble with semiconductors may lead to personal injury, fire or property damage.

Remember to give due consideration to safety when making your circuit designs, with appropriate measures such as (i) placement of substitutive, auxiliary circuits, (ii) use of non-flammable material or (iii) prevention against any malfunction or mishap.

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